



DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} Max	I _D Max T _A = +25°C
30V	1.5Ω @ V _{GS} = 4.5V	0.40A
	2.0Ω @ V _{GS} = 2.5V	0.35A
	3.0Ω @ V _{GS} = 1.8V	0.28A
	4.5Ω @ V _{GS} = 1.5V	0.23A

Description and Applications

This MOSFET is designed to minimize the on-state resistance (RDS(ON)) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- General Purpose Interfacing Switch
- **Power Management Functions**
- Analog Switch

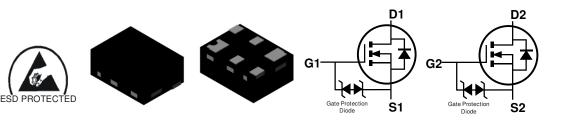
Features and Benefits

- Low On-Resistance
- Very Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Ultra-Small Surface Mount Package 0.8mm x 0.6mm
- **ESD Protected Gate**
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

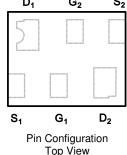
Mechanical Data

- Case: X2-DFN0806-6
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.001 grams (Approximate)

Device Symbol



Bottom View



Ordering Information (Note 4)

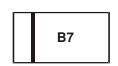
Top View

Part Number	Case	Packaging
DMN31D5UDA-7B	X2-DFN0806-6	10,000/Tape & Reel

Notes:

- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
 See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information



Top View

B7 = Product Type Marking Code

March 2019

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Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V_{DSS}	30	V
Gate-Source Voltage			V _{GSS}	±12	V
Continuous Drain Current (Note 5) V _{GS} = 4.5V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	0.4 0.32	А
Maximum Continuous Body Diode Forward Current (Note 6)			I _S	0.8	Α
Pulsed Drain Current (Note 6)			I _{DM}	0.8	Α

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

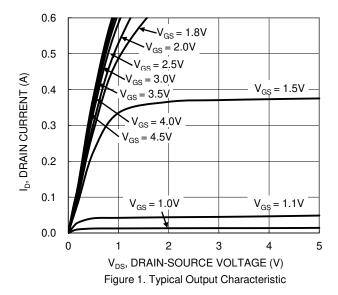
Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P _D	0.37	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	339	°C/W
Operating and Storage Temperature Range	$T_{J,}T_{STG}$	-55 to +150	°C

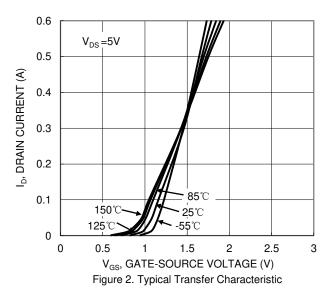
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

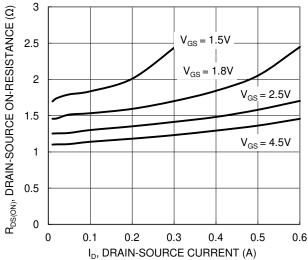
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current @T _C = +25	5°C I _{DSS}	_	_	100	nA	V _{DS} = 24V, V _{GS} = 0V
Gate-Source Leakage	Igss	_	_	±10	μΑ	$V_{GS} = \pm 10V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(TH)}	0.4	0.7	1.0	V	$V_{DS}=V_{GS},\ I_D=250\mu A$
		_	1.2	1.5	Ω	$V_{GS} = 4.5V, I_D = 100mA$
Static Drain-Source On-Resistance	D	_	1.3	2.0		$V_{GS} = 2.5V$, $I_D = 50mA$
Static Drain-Source On-Nesistance	R _{DS(ON)}	_	1.5	3.0		$V_{GS} = 1.8V$, $I_D = 20mA$
		_	1.8	4.5		$V_{GS} = 1.5V, I_D = 10mA$
Diode Forward Voltage		_	0.6	1.0	V	$V_{GS} = 0V$, $I_S = 10mA$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	_	22.6	_	pF	V 45V V 6V
Output Capacitance	Coss	_	2.68	_	pF	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	1.8	_	pF	1 = 1.0WH12
Total Gate Charge	Qg	_	0.38	_	nC	V 45V V 45V
Gate-Source Charge	Qgs	_	0.05	_	nC	$V_{GS} = 4.5V, V_{DS} = 15V,$ $I_{D} = 200 \text{mA}$
Gate-Drain Charge	Q _{gd}	_	0.07	_	nC	- ID = 200IIIA
Turn-On Delay Time	t _{D(ON)}	_	3.2	_	ns	
Turn-On Rise Time		_	2.2	_	ns	$V_{DD} = 15V, V_{GS} = 4.5V,$
Turn-Off Delay Time	t _{D(OFF)}	_	21	_	ns	$R_G = 2\Omega$, $I_D = 200mA$
Turn-Off Fall Time	t _F	_	7.5		ns	

- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout.
- 6. Device mounted on minimum recommended pad layout test board, 10µs pulse duty cycle = 1%.
- 7. Short duration pulse test used to minimize self-heating effect.
 8. Guaranteed by design. Not subject to product testing.









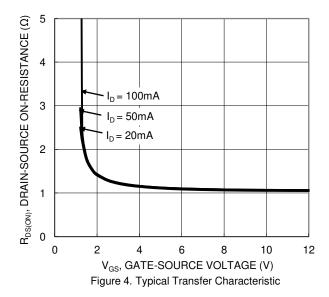
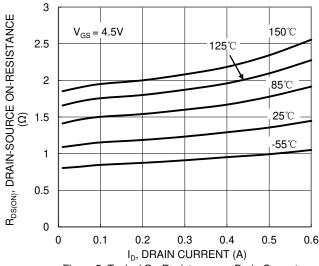


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage



1.8 R_{DS(ON)}, DRAIN-SOURCE ON-RESISTANCE 1.6 $V_{GS} = 2.5V, I_D = 50mA$ 1.4 (NORMALIZED) $V_{GS} = 1.5V, I_{D} = 10mA$ 1.2 $V_{GS} = 1.8V, I_D = 20mA$ 1 8.0 0.6 -50 -25 0 25 50 100 125 150 75 T_J, JUNCTION TEMPERATURE (°C)

Figure 5. Typical On-Resistance vs. Drain Current and Temperature

Figure 6. On-Resistance Variation with Temperature



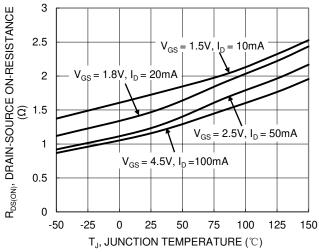


Figure 7. On-Resistance Variation with Temperature

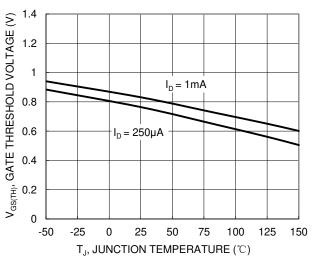
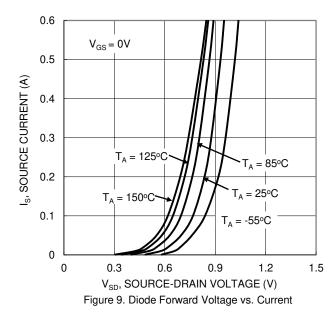


Figure 8. Gate Threshold Variation vs. Junction Temperature



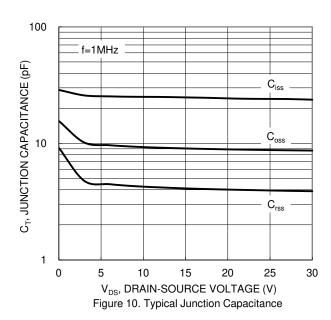
3 \geq 2.5 \leq 2.5 \leq 2 \leq 1.5 \leq 1 0.5

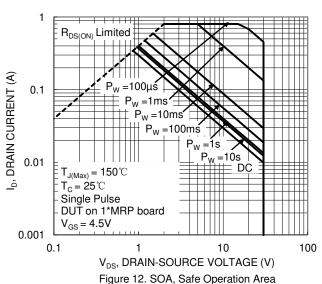
0.2

 $\begin{aligned} &Q_{g}\left(nC\right) \\ &\text{Figure 11. Gate Charge} \end{aligned}$

0.3

0.4





0

0

0.1

4.5

4 3.5

0.5



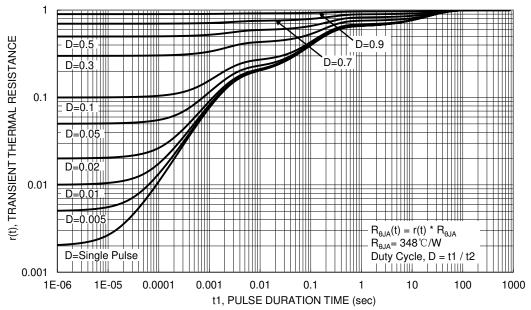


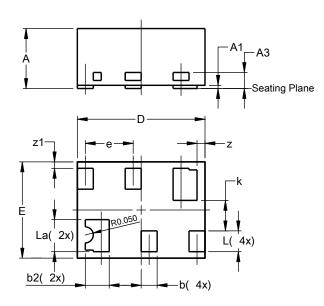
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-DFN0806-6

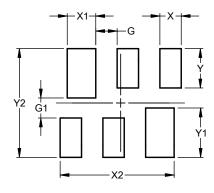


X2-DFN0806-6						
Dim	Min	Max	Тур			
Α		0.40	0.36			
A 1	0.00	0.03	0.02			
A3			0.10			
b	0.07	0.15	0.10			
b2	0.10	0.20	0.15			
D	0.75	0.85	0.80			
Е	0.55	0.65	0.60			
е			0.30			
k			0.19			
L	0.10	0.18	0.13			
La	0.17	0.25	0.20			
Z			0.05			
z 1			0.04			
All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-DFN0806-6



Dimensions	Value (in mm)			
Dillielisions	value (III IIIII)			
G	0.150			
G1	0.140			
Х	0.150			
X1	0.200			
X2	0.800			
Υ	0.275			
Y1	0.345			
Y2	0.760			



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